

**Notice of References Cited**

Application/Control No.

10/594,459

Applicant(s)/Patent Under  
Reexamination  
TAKAHASHI ET AL.

Examiner

/Laura S. Weiner/

Art Unit

1795

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0229123	11-2004	Takahashi et al.	429/231.3
	C	US-			
	D	US-			
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	F	US-			
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	L	US-			
	M	US-			

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	N	EP 1 391 959 A2	02-2004	Europe	Kitao et al.	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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